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### What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Active
Core Processor	HCS12X
Core Size	16-Bit
Speed	80MHz
Connectivity	CANbus, EBI/EMI, I <sup>2</sup> C, IrDA, LINbus, SCI, SPI
Peripherals	LVD, POR, PWM, WDT
Number of I/O	91
Program Memory Size	512KB (512K x 8)
Program Memory Type	FLASH
EEPROM Size	4K x 8
RAM Size	20K x 8
Voltage - Supply (Vcc/Vdd)	2.35V ~ 5.5V
Data Converters	A/D 16x10b
Oscillator Type	External
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	112-LQFP
Supplier Device Package	112-LQFP (20x20)
Purchase URL	<a href="https://www.e-xfl.com/pro/item?MUrl=&amp;PartUrl=mc9s12xdt512mal">https://www.e-xfl.com/pro/item?MUrl=&amp;PartUrl=mc9s12xdt512mal</a>

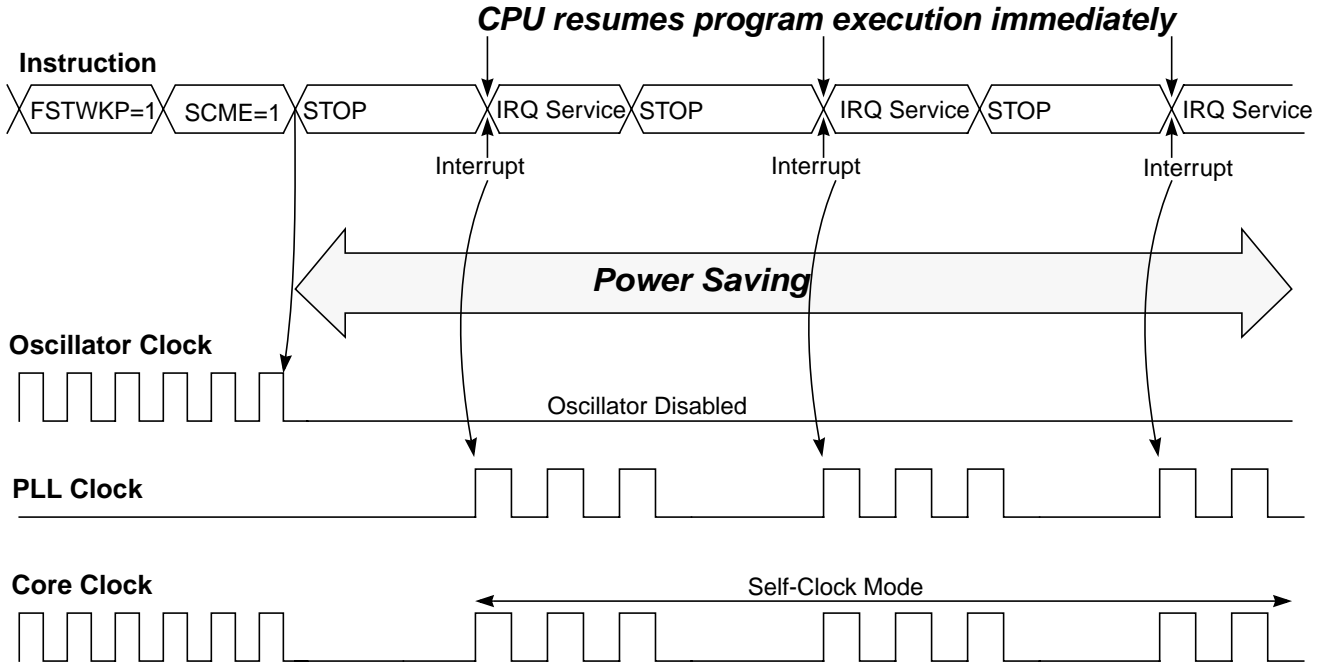


Figure 2-23. Fast Wake-up from Full Stop Mode: Example 1

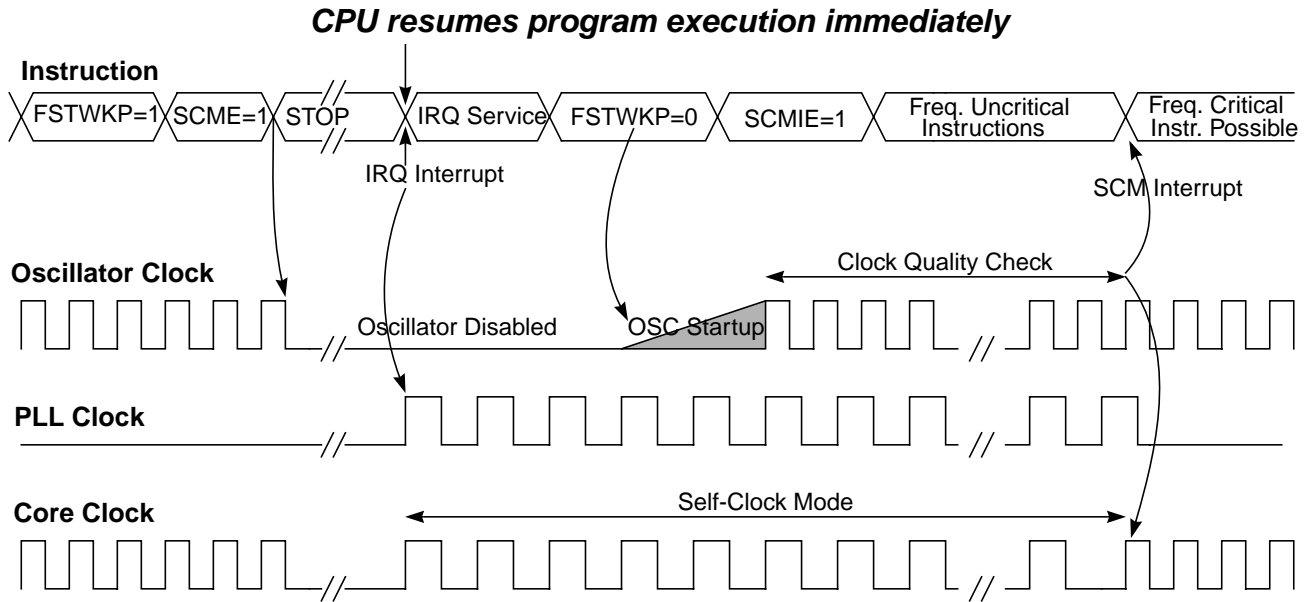


Figure 2-24. Fast Wake-up from Full Stop Mode: Example 2

**Table 4-10. ATD Behavior in Freeze Mode (Breakpoint)**

FRZ1	FRZ0	Behavior in Freeze Mode
0	0	Continue conversion
0	1	Reserved
1	0	Finish current conversion, then freeze
1	1	Freeze Immediately

### 5.3.2.13 ATD Conversion Result Registers (ATDDR<sub>x</sub>)

The A/D conversion results are stored in 8 read-only result registers. The result data is formatted in the result registers based on two criteria. First there is left and right justification; this selection is made using the DJM control bit in ATDCTL5. Second there is signed and unsigned data; this selection is made using the DSGN control bit in ATDCTL5. Signed data is stored in 2's complement format and only exists in left justified format. Signed data selected for right justified format is ignored.

Read: Anytime

Write: Anytime in special mode, unimplemented in normal modes

#### 5.3.2.13.1 Left Justified Result Data

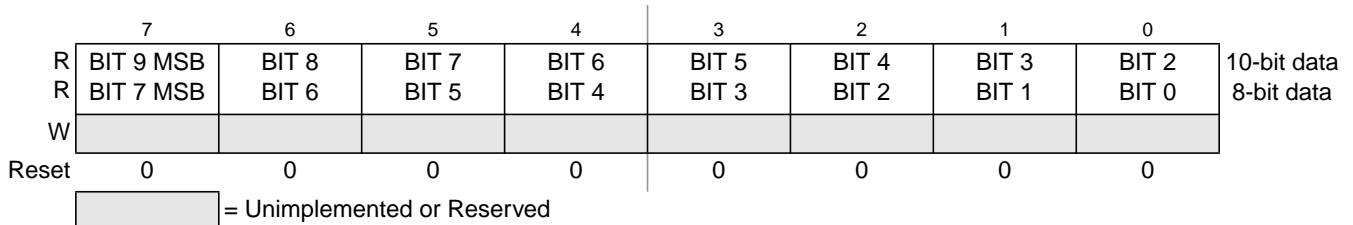


Figure 5-15. Left Justified, ATD Conversion Result Register, High Byte (ATDDR<sub>x</sub>H)

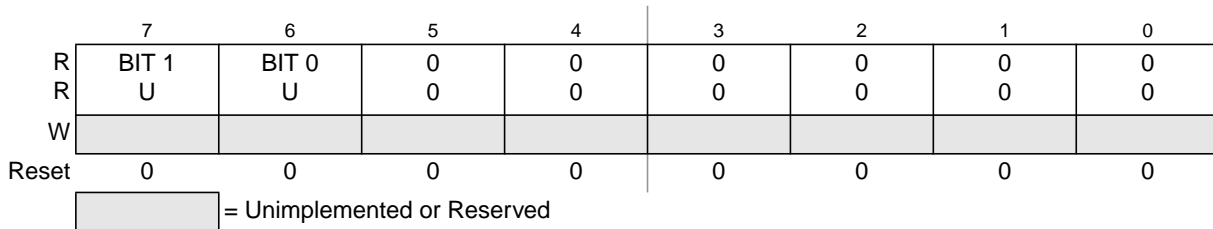


Figure 5-16. Left Justified, ATD Conversion Result Register, Low Byte (ATDDR<sub>x</sub>L)

#### 5.3.2.13.2 Right Justified Result Data

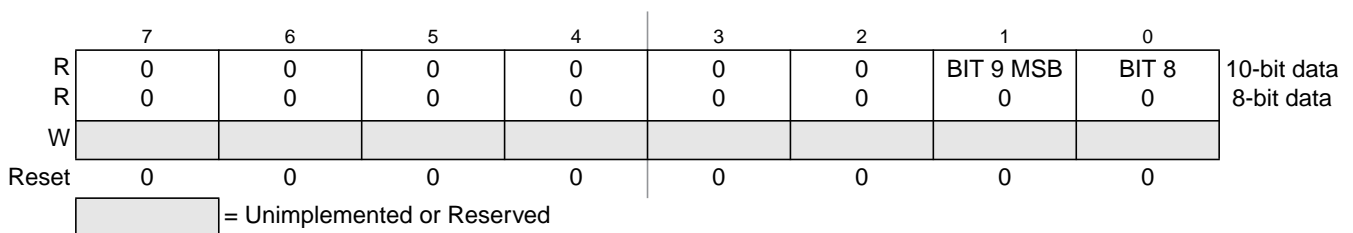


Figure 5-17. Right Justified, ATD Conversion Result Register, High Byte (ATDDR<sub>x</sub>H)

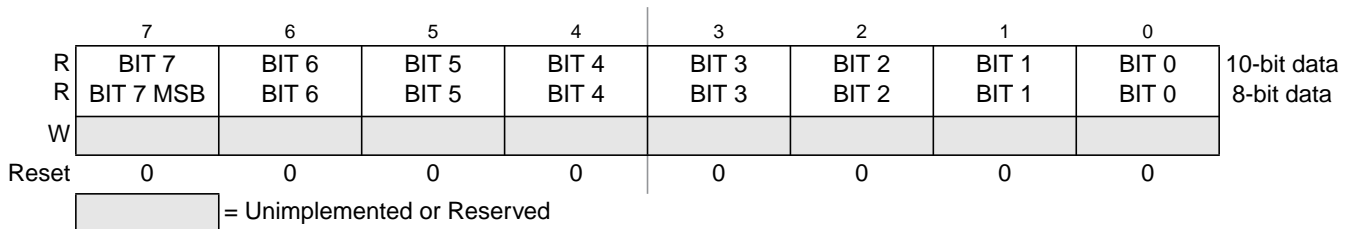


Figure 5-18. Right Justified, ATD Conversion Result Register, Low Byte (ATDDR<sub>x</sub>L)

# LDB

## Load Byte from Memory (Low Byte)

# LDB

### Operation

$M[RB, \#OFFS5 \Rightarrow RD.L; \$00 \Rightarrow RD.H]$   
 $M[RB, RI] \Rightarrow RD.L; \$00 \Rightarrow RD.H$   
 $M[RB, RI] \Rightarrow RD.L; \$00 \Rightarrow RD.H; RI+1 \Rightarrow RI;$ <sup>1</sup>  
 $RI-1 \Rightarrow RI; M[RS, RI] \Rightarrow RD.L; \$00 \Rightarrow RD.H$

Loads a byte from memory into the low byte of register RD. The high byte is cleared.

### CCR Effects

**N Z V C**

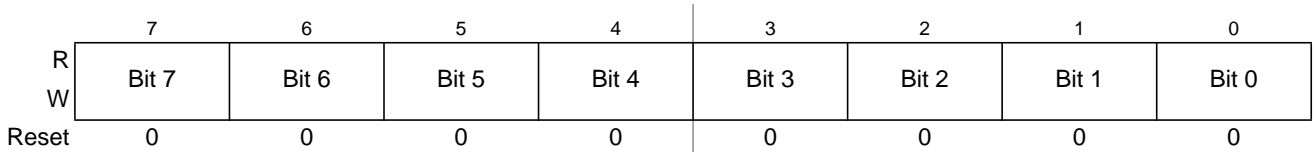
—	—	—	—
---	---	---	---

- N: Not affected.
- Z: Not affected.
- V: Not affected.
- C: Not affected.

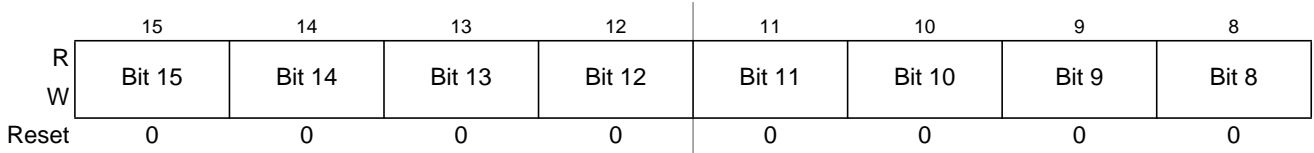
### Code and CPU Cycles

Source Form	Address Mode	Machine Code								Cycles		
		0	1	0	0	0	RD	RB	OFFS5			
LDB RD, (RB, #OFFS5)	IDO5	0	1	0	0	0	RD	RB	OFFS5		Pr	
LDB RD, (RS, RI)	IDR	0	1	1	0	0	RD	RB	RI	0	0	Pr
LDB RD, (RS, RI+)	IDR+	0	1	1	0	0	RD	RB	RI	0	1	Pr
LDB RD, (RS, -RI)	-IDR	0	1	1	0	0	RD	RB	RI	1	0	Pr

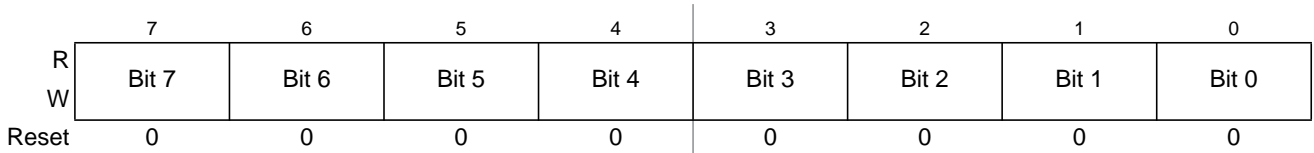
1. If the same general purpose register is used as index (RI) and destination register (RD), the content of the register will not be incremented after the data move:  $M[RB, RI] \Rightarrow RD.L; \$00 \Rightarrow RD.H$



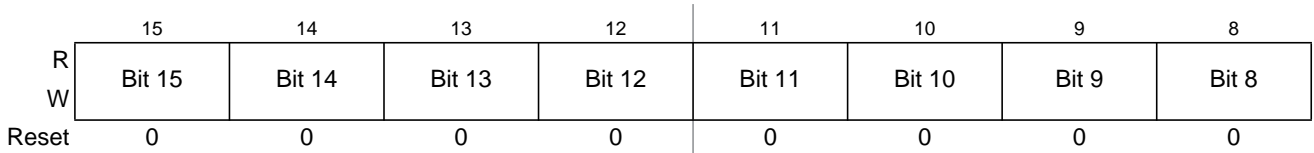
**Figure 7-26. Timer Input Capture/Output Compare Register 3 Low (TC3)**



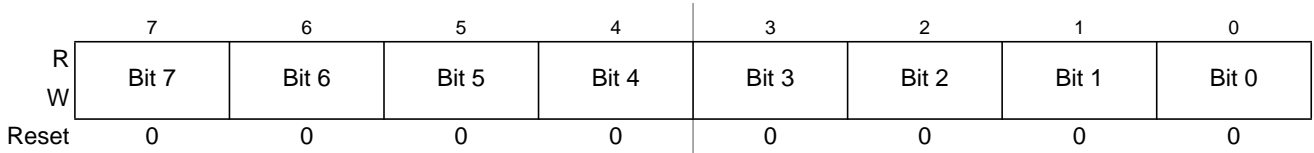
**Figure 7-27. Timer Input Capture/Output Compare Register 4 High (TC4)**



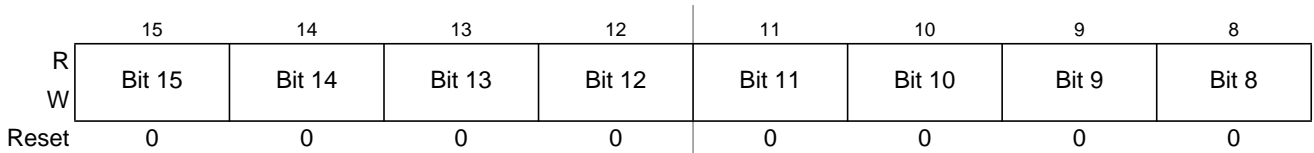
**Figure 7-28. Timer Input Capture/Output Compare Register 4 Low (TC4)**



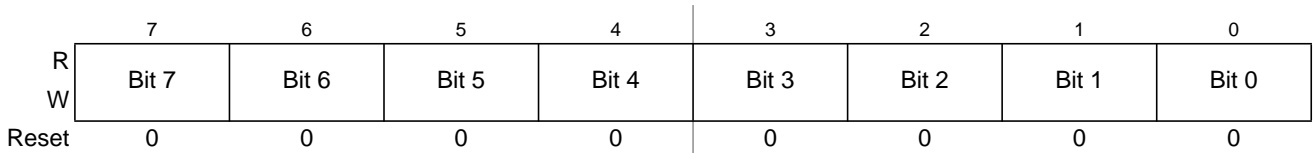
**Figure 7-29. Timer Input Capture/Output Compare Register 5 High (TC5)**



**Figure 7-30. Timer Input Capture/Output Compare Register 5 Low (TC5)**



**Figure 7-31. Timer Input Capture/Output Compare Register 6 High (TC6)**



**Figure 7-32. Timer Input Capture/Output Compare Register 6 Low (TC6)**

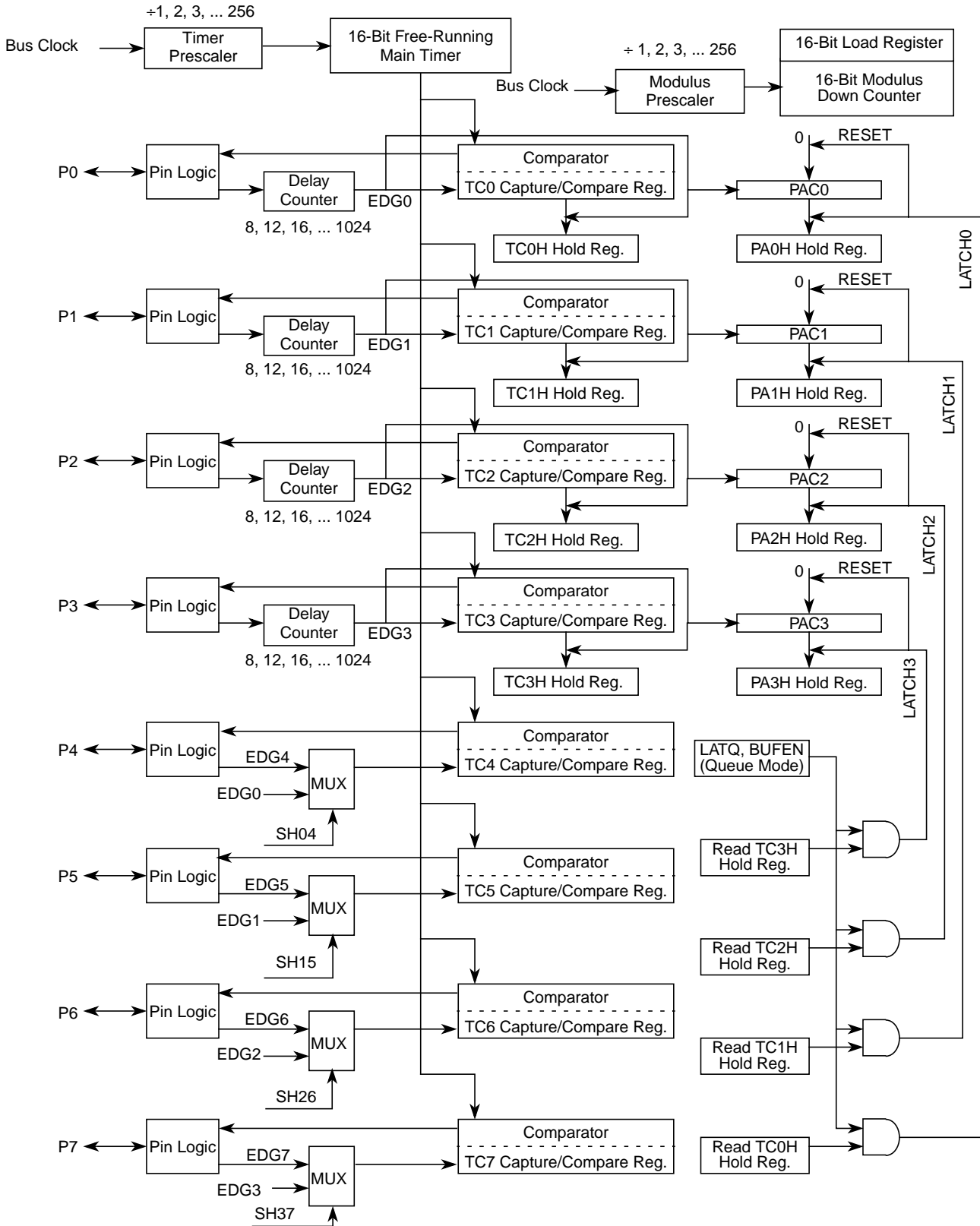


Figure 7-68. Detailed Timer Block Diagram in Queue Mode when PRNT = 1

If the MSCAN is configured for user request (BORM set in [Section 10.3.2.2](#), “MSCAN Control Register 1 (CANCTL1)”), the recovery from bus-off starts after both independent events have become true:

- 128 occurrences of 11 consecutive recessive bits on the CAN bus have been monitored
- BOHOLD in [Section 10.3.2.14](#), “MSCAN Miscellaneous Register (CANMISC) has been cleared by the user

These two events may occur in any order.



### 19.4.2.2 Exact Address Comparator Match (Comparators B and D)

Comparators B and D feature SZ and SZE control bits. If SZE is clear, then the comparator address match qualification functions the same as for comparators A and C.

If the SZE bit is set the access size (word or byte) is compared with the SZ bit value such that only the specified type of access causes a match. Thus, if configured for a byte access of a particular address, a word access covering the same address does not lead to match.

**Table 19-37. Comparator Access Size Considerations**

Comparator	Address	SZE	SZ8	Condition For Valid Match
Comparators A and C	ADDR[n]	-	-	Word and byte accesses of ADDR[n] <sup>1</sup> MOVB #\$BYTE ADDR[n] MOVW #\$WORD ADDR[n]
Comparators B and D	ADDR[n]	0	X	Word and byte accesses of ADDR[n] <sup>1</sup> MOVB #\$BYTE ADDR[n] MOVW #\$WORD ADDR[n]
Comparators B and D	ADDR[n]	1	0	Word accesses of ADDR[n] <sup>1</sup> MOVW #\$WORD ADDR[n]
Comparators B and D	ADDR[n]	1	1	Byte accesses of ADDR[n] MOVB #\$BYTE ADDR[n]

<sup>1</sup> A word access of ADDR[n-1] also accesses ADDR[n] but does not generate a match. The comparator address register must contain the exact address used in the code.

### 19.4.2.3 Range Comparisons

When using the AB comparator pair for a range comparison, the data bus can also be used for qualification by using the comparator A data and data mask registers. Furthermore the DBGACTL RW and RWE bits can be used to qualify the range comparison on either a read or a write access. The corresponding DBGBCCTL bits are ignored. Similarly when using the CD comparator pair for a range comparison, the data bus can also be used for qualification by using the comparator C data and data mask registers. Furthermore the DBGCCCTL RW and RWE bits can be used to qualify the range comparison on either a read or a write access if tagging is not selected. The corresponding DBGDCCTL bits are ignored. The SZE and SZ control bits are ignored in range mode. The comparator A and C TAG bits are used to tag range comparisons for the AB and CD ranges respectively. The comparator B and D TAG bits are ignored in range modes. In order for a range comparison using comparators A and B, both COMPEA and COMPEB must be set; to disable range comparisons both must be cleared. Similarly for a range CD comparison, both COMPEC and COMPED must be set. If a range mode is selected SRCA and SRCB must select the same source (S12X or XGATE). Similarly SRCC and SRCD must select the same source. When configured for range comparisons and tagging, the ranges are accurate only to word boundaries.

#### 19.4.2.3.1 Inside Range (CompAC\_Addr ≤ Address ≤ CompBD\_Addr)

In the inside range comparator mode, either comparator pair A and B or comparator pair C and D can be configured for range comparisons. This configuration depends upon the control register (DBGC2). The match condition requires that a valid match for both comparators happens on the same bus cycle. A match condition on only one comparator is not valid. An aligned word access which straddles the range boundary will cause a trigger only if the aligned address is inside the range.

**Table 20-2. External System Pins Associated With S12XDBG**

Pin Name	Pin Functions	Description
$\overline{\text{TAGHI}}$ (See DUG)	TAGHI	When instruction tagging is on, tags the high half of the instruction word being read into the instruction queue.
$\overline{\text{TAGLO}}$ (See DUG)	TAGLO	When instruction tagging is on, tags the low half of the instruction word being read into the instruction queue.
$\overline{\text{TAGLO}}$ (See DUG)	Unconditional Tagging Enable	In emulation modes, a low assertion on this pin in the 7th or 8th cycle after the end of reset enables the Unconditional Tagging function.

## 20.3 Memory Map and Registers

### 20.3.1 Module Memory Map

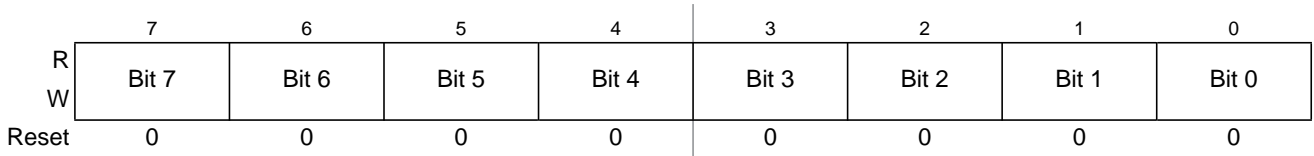
A summary of the registers associated with the S12XDBG sub-block is shown in [Table 20-2](#). Detailed descriptions of the registers and bits are given in the subsections that follow.

Address	Name		Bit 7	6	5	4	3	2	1	Bit 0
0x0020	DBGC1	R W	ARM	0 TRIG	XGSBPE	BDM		DBGBRK		COMRV
0x0021	DBGSR	R W	TBF	EXTF	0	0	0	SSF2	SSF1	SSF0
0x0022	DBGTCR	R W	TSOURCE		TRANGE		TRCMOD		TALIGN	
0x0023	DBGC2	R W	0	0	0	0	CDCM		ABCM	
0x0024	DBGTBH	R W	Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8
0x0025	DBGTBL	R W	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
0x0026	DBGCNT	R W	0	CNT						
0x0027	DBGSCRX	R W	0	0	0	0	SC3	SC2	SC1	SC0
0x0027	DBGMFR	R W	0	0	0	0	MC3	MC2	MC1	MC0
0x0028 <sup>1</sup>	DBGXCTL (COMPA/C)	R W	0	NDB	TAG	BRK	RW	RWE	SRC	COMPE
0x0028 <sup>2</sup>	DBGXCTL (COMPB/D)	R W	SZE	SZ	TAG	BRK	RW	RWE	SRC	COMPE
0x0029	DBGXAH	R W	0	Bit 22	21	20	19	18	17	Bit 16

**Figure 20-2. Quick Reference to S12XDBG Registers**

### 20.3.2.8.8 Debug Comparator Data Low Mask Register (DBGXDLM)

Address: 0x002F



**Figure 20-21. Debug Comparator Data Low Mask Register (DBGXDLM)**

Read: Anytime

Write: Anytime when S12XDBG not armed.

**Table 20-35. DBGXDLM Field Descriptions**

Field	Description
7–0 Bits[7:0]	<p><b>Comparator Data Low Mask Bits</b> — The Comparator data low mask bits control whether the selected comparator compares the data bus bits [7:0] to the corresponding comparator data compare bits. This register is available only for comparators A and C.</p> <p>0 Do not compare corresponding data bit 1 Compare corresponding data bit</p>

## 20.4 Functional Description

This section provides a complete functional description of the S12XDBG module. If the part is in secure mode, the S12XDBG module can generate breakpoints but tracing is not possible.

### 20.4.1 S12XDBG Operation

Arming the S12XDBG module by setting ARM in DBGCR1 allows triggering, and storing of data in the trace buffer and can be used to cause breakpoints to the S12XCPU or the XGATE module. The DBG module is made up of four main blocks, the comparators, control logic, the state sequencer, and the trace buffer.

The comparators monitor the bus activity of the S12XCPU and XGATE modules. Comparators can be configured to monitor address and databus. Comparators can also be configured to mask out individual data bus bits during a compare and to use R/W and word/byte access qualification in the comparison. When a match with a comparator register value occurs the associated control logic can trigger the state sequencer to another state (see Figure 20-23). Either forced or tagged triggers are possible. Using a forced trigger, the trigger is generated immediately on a comparator match. Using a tagged trigger, at a comparator match, the instruction opcode is tagged and only if the instruction reaches the execution stage of the instruction queue is a trigger generated. In the case of a transition to Final State, bus tracing is triggered and/or a breakpoint can be generated. Tracing of both S12XCPU and/or XGATE bus activity is possible.

Independent of the state sequencer, a breakpoint can be triggered by the external  $\overline{\text{TAGHI}}$  /  $\overline{\text{TAGLO}}$  signals, by an XGATE S/W breakpoint request or by writing to the TRIG bit in the DBGCR1 control register.

Comparators A and C feature an NDB control bit to determine if a match occurs when the data bus differs to comparator register contents or when the data bus is equivalent to the comparator register contents.

### 20.4.2.2 Exact Address Comparator Match (Comparators B and D)

Comparators B and D feature SZ and SZE control bits. If SZE is clear, then the comparator address match qualification functions the same as for comparators A and C.

If the SZE bit is set the access size (word or byte) is compared with the SZ bit value such that only the specified type of access causes a match. Thus if configured for a byte access of a particular address, a word access covering the same address does not lead to match.

**Table 20-37. Comparator Access Size Considerations**

Comparator	Address	SZE	SZ8	Condition For Valid Match
Comparators A and C	ADDR[n]	—	—	Word and byte accesses of ADDR[n] <sup>1</sup> MOVB #\$\$BYTE ADDR[n] MOVW #\$\$WORD ADDR[n]
Comparators B and D	ADDR[n]	0	X	Word and byte accesses of ADDR[n] <sup>1</sup> MOVB #\$\$BYTE ADDR[n] MOVW #\$\$WORD ADDR[n]
Comparators B and D	ADDR[n]	1	0	Word accesses of ADDR[n] <sup>1</sup> MOVW #\$\$WORD ADDR[n]
Comparators B and D	ADDR[n]	1	1	Byte accesses of ADDR[n] MOVB #\$\$BYTE ADDR[n]

<sup>1</sup> A word access of ADDR[n-1] also accesses ADDR[n] but does not generate a match. The comparator address register must contain the exact address used in the code.

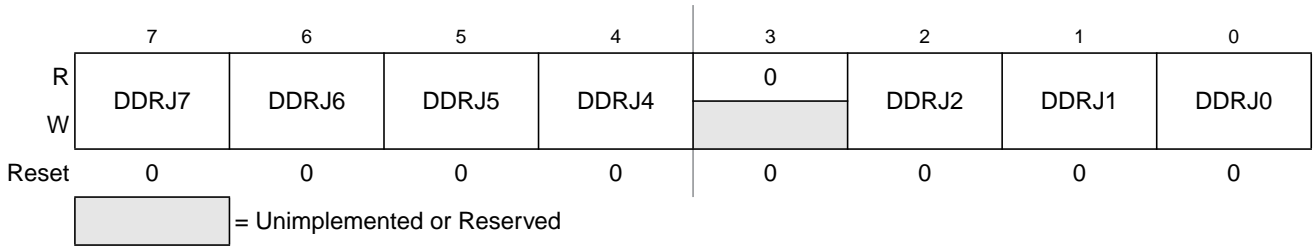
### 20.4.2.3 Range Comparisons

When using the AB comparator pair for a range comparison, the data bus can also be used for qualification by using the comparator A data and data mask registers. Furthermore the DBGACTL RW and RWE bits can be used to qualify the range comparison on either a read or a write access. The corresponding DBGBCTL bits are ignored. Similarly when using the CD comparator pair for a range comparison, the data bus can also be used for qualification by using the comparator C data and data mask registers. Furthermore the DBGCCCTL RW and RWE bits can be used to qualify the range comparison on either a read or a write access if tagging is not selected. The corresponding DBGDCTL bits are ignored. The SZE and SZ control bits are ignored in range mode. The comparator A and C TAG bits are used to tag range comparisons for the AB and CD ranges respectively. The comparator B and D TAG bits are ignored in range modes. In order for a range comparison using comparators A and B, both COMPEA and COMPEB must be set; to disable range comparisons both must be cleared. Similarly for a range CD comparison, both COMPEC and COMPED must be set. If a range mode is selected SRCA and SRCC select the source (S12X or XGATE), SRCB and SRCD are ignored. When configured for range comparisons and tagging, the ranges are accurate only to word boundaries.

#### 20.4.2.3.1 Inside Range (CompAC\_Addr ≤ address ≤ CompBD\_Addr)

In the Inside Range comparator mode, either comparator pair A and B or comparator pair C and D can be configured for range comparisons. This configuration depends upon the control register (DBGC2). The

### 22.3.2.56 Port J Data Direction Register (DDRJ)



**Figure 22-58. Port J Data Direction Register (DDRJ)**

Read: Anytime.

Write: Anytime.

This register configures each port J pin as either input or output.

The CAN forces the I/O state to be an output on PJ7 (TXCAN4) and an input on pin PJ6 (RXCAN4). The IIC takes control of the I/O if enabled. In these cases the data direction bits will not change.

The SCI2 forces the I/O state to be an output for each port line associated with an enabled output (TXD2). It also forces the I/O state to be an input for each port line associated with an enabled input (RXD2). In these cases the data direction bits will not change.

The DDRJ bits revert to controlling the I/O direction of a pin when the associated peripheral module is disabled.

**Table 22-52. DDRJ Field Descriptions**

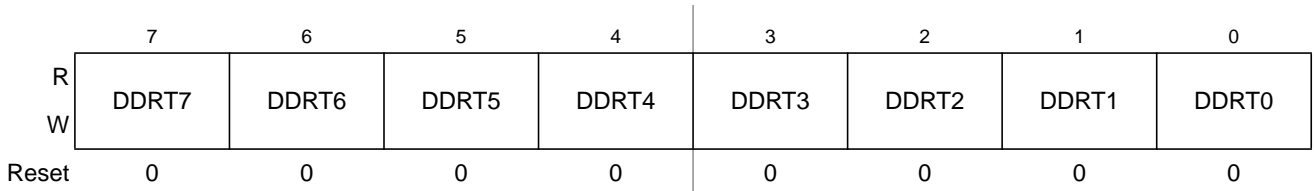
Field	Description
7-0 DDRJ[7:4] DDRJ[2:0]	<p><b>Data Direction Port J</b></p> <p>0 Associated pin is configured as input. 1 Associated pin is configured as output.</p> <p><b>Note:</b> Due to internal synchronization circuits, it can take up to 2 bus clock cycles until the correct value is read on PTJ or PTIJ registers, when changing the DDRJ register.</p>



**Table 23-22. PTIT Field Descriptions**

Field	Description
7–0 PTIT[7:0]	<b>Port T Input</b> — This register always reads back the buffered state of the associated pins. This can also be used to detect overload or short circuit conditions on output pins.

### 23.0.5.19 Port T Data Direction Register (DDRT)



**Figure 23-21. Port T Data Direction Register (DDRT)**

Read: Anytime.

Write: Anytime.

This register configures each port T pin as either input or output.

The ECT forces the I/O state to be an output for each timer port associated with an enabled output compare. In this case the data direction bits will not change.

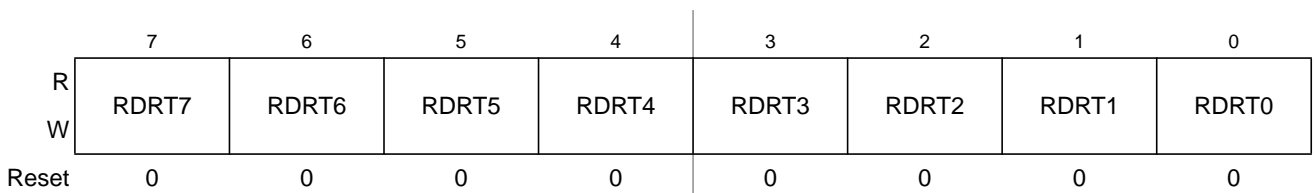
The DDRT bits revert to controlling the I/O direction of a pin when the associated timer output compare is disabled.

The timer input capture always monitors the state of the pin.

**Table 23-23. DDRT Field Descriptions**

Field	Description
7–0 DDRT[7:0]	<b>Data Direction Port T</b> 0 Associated pin is configured as input. 1 Associated pin is configured as output. <b>Note:</b> Due to internal synchronization circuits, it can take up to 2 bus clock cycles until the correct value is read on PTT or PTIT registers, when changing the DDRT register.

### 23.0.5.20 Port T Reduced Drive Register (RDRT)



**Figure 23-22. Port T Reduced Drive Register (RDRT)**

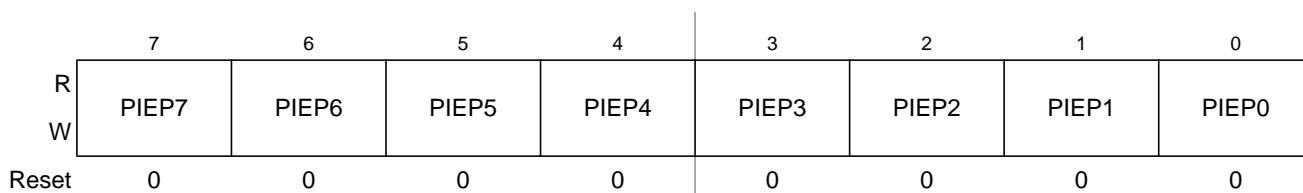
Read: Anytime.

Write: Anytime.

**Table 24-38. PPSP Field Descriptions**

Field	Description
7–0 PPSP[7:0]	<p><b>Polarity Select Port P</b></p> <p>0 Falling edge on the associated port P pin sets the associated flag bit in the PIFP register. A pull-up device is connected to the associated port P pin, if enabled by the associated bit in register PERP and if the port is used as input.</p> <p>1 Rising edge on the associated port P pin sets the associated flag bit in the PIFP register. A pull-down device is connected to the associated port P pin, if enabled by the associated bit in register PERP and if the port is used as input.</p>

#### 24.0.5.40 Port P Interrupt Enable Register (PIEP)



**Figure 24-42. Port P Interrupt Enable Register (PIEP)**

Read: Anytime.

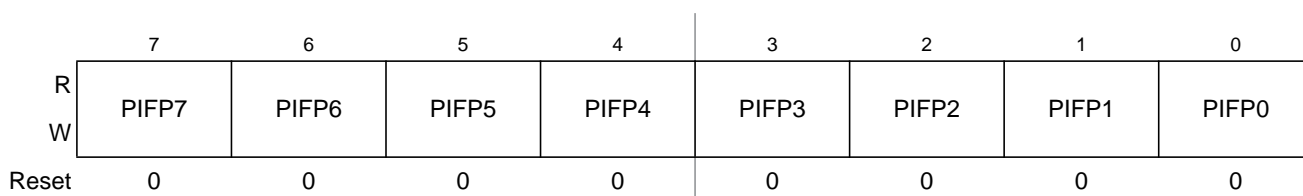
Write: Anytime.

This register disables or enables on a per-pin basis the edge sensitive external interrupt associated with Port P.

**Table 24-39. PIEP Field Descriptions**

Field	Description
7–0 PIEP[7:0]	<p><b>Interrupt Enable Port P</b></p> <p>0 Interrupt is disabled (interrupt flag masked).</p> <p>1 Interrupt is enabled.</p>

#### 24.0.5.41 Port P Interrupt Flag Register (PIFP)



**Figure 24-43. Port P Interrupt Flag Register (PIFP)**

Read: Anytime.

Write: Anytime.

Each flag is set by an active edge on the associated input pin. This could be a rising or a falling edge based on the state of the PPSP register. To clear this flag, write logic level “1” to the corresponding bit in the PIFP register. Writing a “0” has no effect.



## 28.6.1 Unsecuring the MCU using Backdoor Key Access

The MCU may be unsecured by using the backdoor key access feature which requires knowledge of the contents of the backdoor keys (four 16-bit words programmed at addresses 0x7F\_FF00–0x7F\_FF07). If the KEYEN[1:0] bits are in the enabled state (see Section 28.3.2.2, “Flash Security Register (FSEC)”) and the KEYACC bit is set, a write to a backdoor key address in the Flash memory triggers a comparison between the written data and the backdoor key data stored in the Flash memory. If all four words of data are written to the correct addresses in the correct order and the data matches the backdoor keys stored in the Flash memory, the MCU will be unsecured. The data must be written to the backdoor keys sequentially starting with 0x7F\_FF00–1 and ending with 0x7F\_FF06–7. 0x0000 and 0xFFFF are not permitted as backdoor keys. While the KEYACC bit is set, reads of the Flash memory will return invalid data.

The user code stored in the Flash memory must have a method of receiving the backdoor keys from an external stimulus. This external stimulus would typically be through one of the on-chip serial ports.

If the KEYEN[1:0] bits are in the enabled state (see Section 28.3.2.2, “Flash Security Register (FSEC)”), the MCU can be unsecured by the backdoor key access sequence described below:

1. Set the KEYACC bit in the Flash Configuration Register (FCNFG).
2. Write the correct four 16-bit words to Flash addresses 0xFF00–0xFF07 sequentially starting with 0x7F\_FF00.
3. Clear the KEYACC bit. Depending on the user code used to write the backdoor keys, a wait cycle (NOP) may be required before clearing the KEYACC bit.
4. If all four 16-bit words match the backdoor keys stored in Flash addresses 0x7F\_FF00–0x7F\_FF07, the MCU is unsecured and the SEC[1:0] bits in the FSEC register are forced to the unsecure state of 1:0.

The backdoor key access sequence is monitored by an internal security state machine. An illegal operation during the backdoor key access sequence will cause the security state machine to lock, leaving the MCU in the secured state. A reset of the MCU will cause the security state machine to exit the lock state and allow a new backdoor key access sequence to be attempted. The following operations during the backdoor key access sequence will lock the security state machine:

1. If any of the four 16-bit words does not match the backdoor keys programmed in the Flash array.
2. If the four 16-bit words are written in the wrong sequence.
3. If more than four 16-bit words are written.
4. If any of the four 16-bit words written are 0x0000 or 0xFFFF.
5. If the KEYACC bit does not remain set while the four 16-bit words are written.
6. If any two of the four 16-bit words are written on successive MCU clock cycles.

After the backdoor keys have been correctly matched, the MCU will be unsecured. Once the MCU is unsecured, the Flash security byte can be programmed to the unsecure state, if desired.

In the unsecure state, the user has full control of the contents of the backdoor keys by programming addresses 0x7F\_FF00–0x7F\_FF07 in the Flash Configuration Field.

The security as defined in the Flash security byte (0x7F\_FF0F) is not changed by using the backdoor key access sequence to unsecure. The backdoor keys stored in addresses 0x7F\_FF00–0x7F\_FF07 are

The meaning of the bits KEYEN[1:0] is shown in Table 30-2. Please refer to Section 30.1.5.1, “Unsecuring the MCU Using the Backdoor Key Access” for more information.

**Table 30-2. Backdoor Key Access Enable Bits**

KEYEN[1:0]	Backdoor Key Access Enabled
00	0 (disabled)
01	0 (disabled)
10	1 (enabled)
11	0 (disabled)

The meaning of the security bits SEC[1:0] is shown in Table 30-3. For security reasons, the state of device security is controlled by two bits. To put the device in unsecured mode, these bits must be programmed to SEC[1:0] = ‘10’. All other combinations put the device in a secured mode. The recommended value to put the device in secured state is the inverse of the unsecured state, i.e. SEC[1:0] = ‘01’.

**Table 30-3. Security Bits**

SEC[1:0]	Security State
00	1 (secured)
01	1 (secured)
<b>10</b>	<b>0 (unsecured)</b>
11	1 (secured)

**NOTE**

Please refer to the Flash block guide (FTX) for actual security configuration (in section “Flash Module Security”).

### 30.1.4 Operation of the Secured Microcontroller

By securing the device, unauthorized access to the EEPROM and Flash memory contents can be prevented. However, it must be understood that the security of the EEPROM and Flash memory contents also depends on the design of the application program. For example, if the application has the capability of downloading code through a serial port and then executing that code (e.g. an application containing bootloader code), then this capability could potentially be used to read the EEPROM and Flash memory contents even when the microcontroller is in the secure state. In this example, the security of the application could be enhanced by requiring a challenge/response authentication before any code can be downloaded.

Secured operation has the following effects on the microcontroller:

### A.8.3 Emulation Single-Chip Mode (Without Wait States)

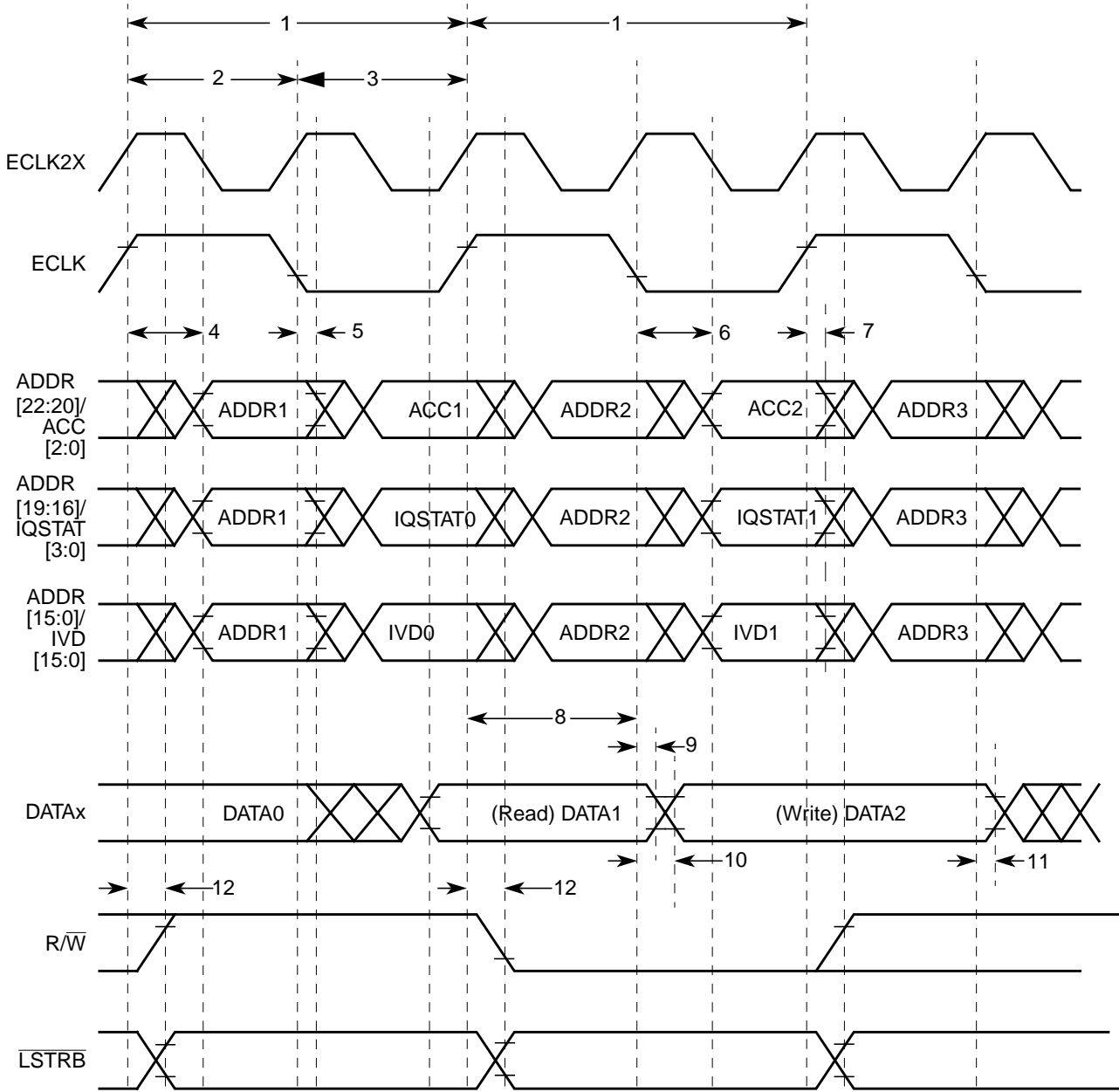


Figure A-14. Example 2a: Emulation Single-Chip Mode — Read Followed by Write

## B.3 80-Pin QFP Package

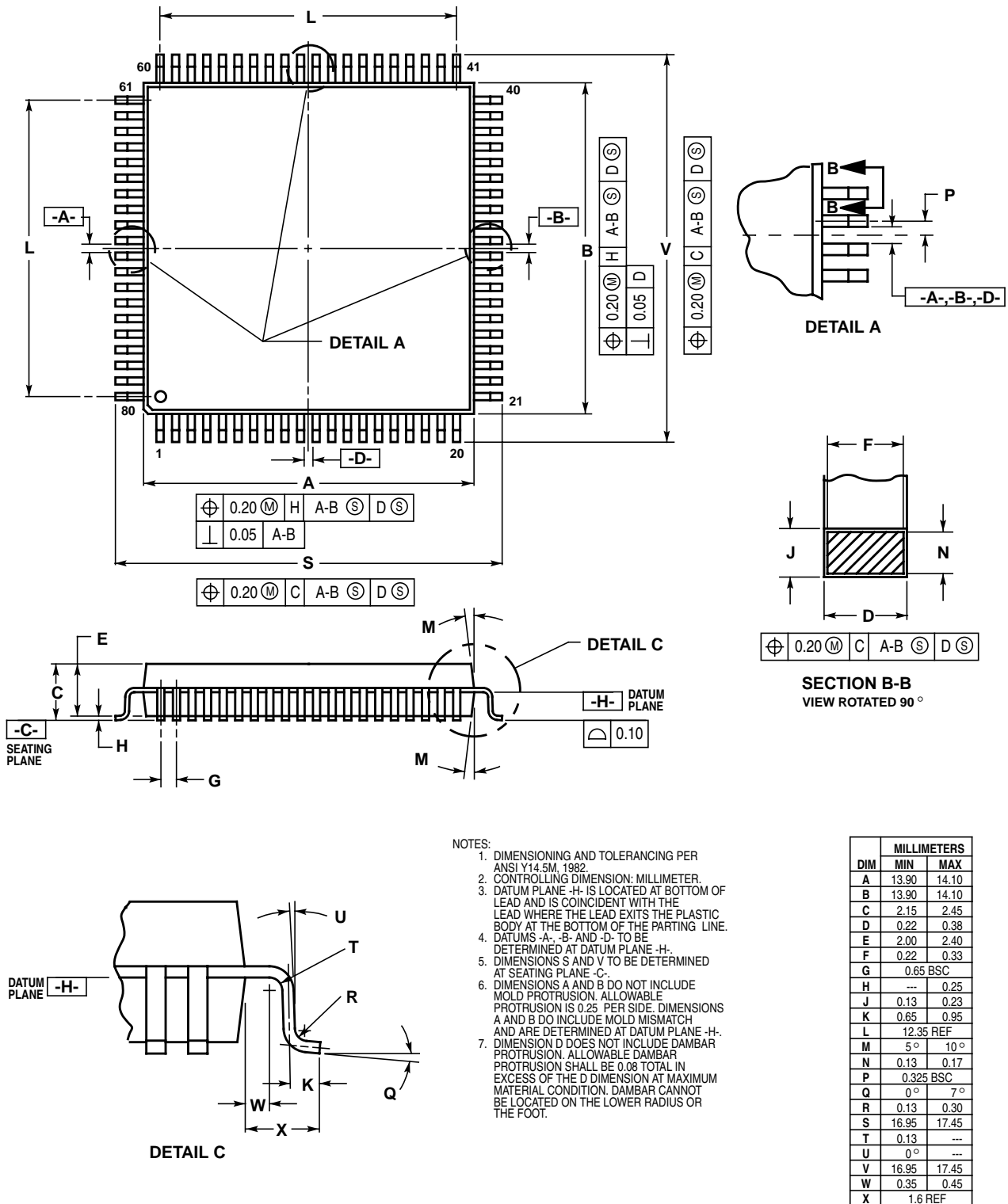


Figure B-3. 80-Pin QFP Mechanical Dimensions (Case No. 841B)

**Table C-1. Recommended Decoupling Capacitor Choice**

Component	Purpose	Type	Value
C1	$V_{DD1}$ filter capacitor	Ceramic	220 nF
C2	$V_{DD2}$ filter capacitor	Ceramic X7R	220 nF
C3	$V_{DDA}$ filter capacitor	Ceramic X7R	$\geq 100$ nF
C4	$V_{DDR}$ filter capacitor	X7R/tantalum	$\geq 100$ nF
C5	$V_{DDPLL}$ filter capacitor	Ceramic X7R	220 nF
C6	$V_{DDX}$ filter capacitor	X7R/tantalum	$\geq 100$ nF
C7	OSC load capacitor	Comes from crystal manufacturer	
C8	OSC load capacitor		
C9	PLL loop filter capacitor	See PLL specification chapter	
C10	PLL loop filter capacitor		
C11	$V_{DDX}$ filter capacitor	X7R/tantalum	$\geq 100$ nF
C12	$V_{DDX}$ filter capacitor	X7R/tantalum	$\geq 100$ nF
R1	PLL loop filter resistor	See PLL specification chapter	
Q1	Quartz	—	—